Notice of References Cited Application/Control No. 10/809,776 Examiner Nicholas S. Ulrich Applicant(s)/Patent Under Reexamination HUREWITZ ET AL. Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,295,242 A	03-1994	Mashruwala et al.	715/853
*	В	US-5,493,658 A	02-1996	Chiang et al.	715/709
*	С	US-5,539,872 A	07-1996	Mintz et al.	715/810
*	D	US-5,801,702 A	09-1998	Dolan et al.	715/854
*	Е	US-5,920,315 A	07-1999	Santos-Gomez, Lucinio	715/792
*	F	US-6,177,936 B1	01-2001	Cragun, Brian John	715/760
*	G	US-2003/0004929 A1	01-2003	Julian et al.	707/2
*	Н	US-2003/0117443 A1	06-2003	Langner et al.	345/810
*	1	US-2003/0160829 A1	08-2003	Miksovsky et al.	345/804
*	J	US-2004/0068431 A1	04-2004	Smith et al.	705/010
*	К	US-2005/0210406 A1	09-2005	Biwer et al.	715/804
*	L	US-7,017,121 B1	03-2006	Gikas et al.	715/804
*	М	US-7,188,317 B1	03-2007	Hazel, Thomas G.	715/804

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	α					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Notice of References Cited Notice of References Cited Nicholas S. Ulrich Application/Control No. Applicant(s)/Patent Under Reexamination HUREWITZ ET AL. Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,408,655 A	04-1995	Oren et al.	715/501.1
*	В	US-5,546,529 A	08-1996	Bowers et al.	715/848
*	С	US-5,594,899 A	01-1997	Knudsen et al.	707/2
*	D	US-5,708,787 A	01-1998	Nakano et al.	715/841
*	Е	US-5,786,818 A	07-1998	Brewer et al.	715/822
*	F	US-5,940,820 A	08-1999	Kagiwada, Keiji	707/3
*	G	US-6,334,131 B1	12-2001	Chakrabarti et al.	707/10
*	Н	US-6,338,067 B1	01-2002	Baker et al.	707/100
*	1	US-6,363,353 B1	03-2002	Chen, Li-Wen	705/10
*	J	US-6,577,304 B1	06-2003	Yablonski et al.	345/419
*	К	US-6,711,589 B2	03-2004	Dietz, Timothy Alan	707/104.1
*	L	US-7,007,029 B1	02-2006	Chen, Li-Wen	707/100
*	М	US-7,149,698 B2	12-2006	Guheen et al.	705/1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
,	0					
	Р				,	
	Q					
	R.					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	v						
	w						
	×						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 10/809,776 Examiner Nicholas S. Ulrich Applicant(s)/Patent Under Reexamination HUREWITZ ET AL. Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0046214 A1	03-2003	Menninger, Anthony Frank	705/37
*	В	US-2002/0099598 A1	07-2002	Eicher et al.	705/11
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	· Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S	_				
	Т			,		

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	\ \ \							
	w							
	x							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.